

# PC352

## Opaque\*, Mini-flat Package, High Resistance to Noise Type Photocoupler

### ■ Features

1. Opaque type, mini-flat package  
**PC352** (1-channel)
  2. High resistance to noise due to high common mode rejection voltage ( $V_{CM}$  : TYP. 1.5kV)
  3. Subminiature type  
(The volume is smaller than that of our conventional DIP type by as far as 30%.)
  4. Isolation voltage between input and output  
**PC352**••• $V_{iso}(rms)$  : 3.75kV
  5. Recognized by UL, file No. E64380
- \* Employs double transfer mold technology

### ■ Applications

1. Programmable controllers

### ■ Package Specifications

Model No.	Package specification
<b>PC352N</b>	Taping reel diameter 370mm (3 000 pcs)
<b>PC352NT</b>	Taping reel diameter 178mm (750 pcs)

### ■ Absolute Maximum Ratings

(Ta=25°C)

	Parameter	Symbol	Rating	Unit
Input	*1 Forward current	$I_F$	50	mA
	*2 Peak forward current	$I_{FM}$	1	A
	Reverse voltage	$V_R$	6	V
	*1 Power dissipation	P	70	mW
Output	*1 Collector-emitter voltage	$V_{CEO}$	35	V
	Emitter-collector voltage	$V_{ECO}$	6	V
	Collector current	$I_C$	50	mA
	*1 Collector dissipation	$P_C$	150	mW
	*1 Total power dissipation	$P_{tot}$	170	mW
	Operating temperature	$T_{opr}$	-30 to +100	°C
	Storage temperature	$T_{stg}$	-40 to +125	°C
	*3 Isolation voltage	$V_{iso}(rms)$	3.75	kV
	*4 Soldering temperature	$T_{SOL}$	260	°C

\*1 The derating factors of absolute maximum ratings due to ambient temperature are shown in Fig.2 to 5

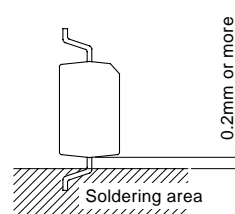
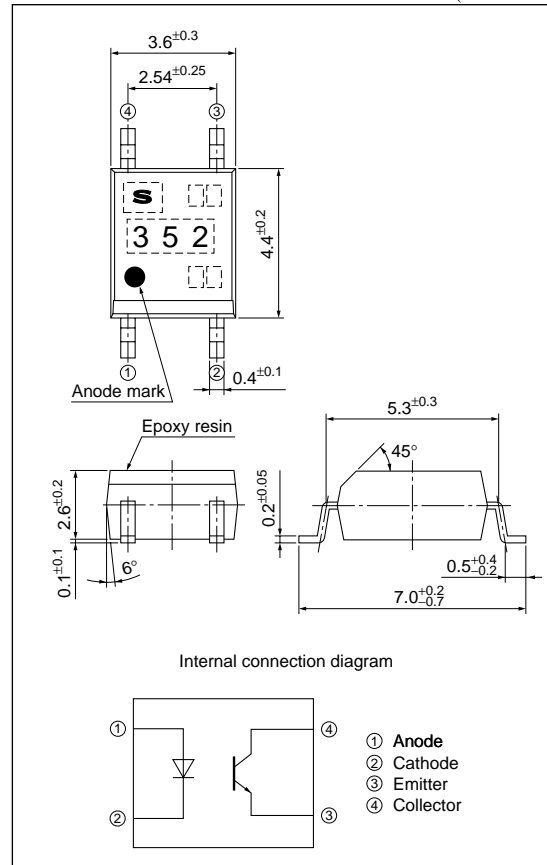
\*2 Pulse width ≤ 100μs, Duty ratio: 0.01, Refer to Fig.6

\*3 AC for 1min., 40 to 60% RH, f=60Hz

\*4 For 10s

### ■ Outline Dimensions

(Unit : mm)



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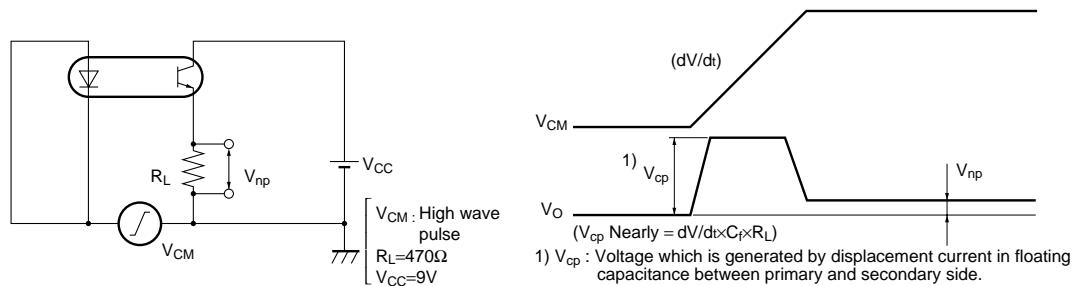
## ■ Electro-optical Characteristics

(Ta=25°C)

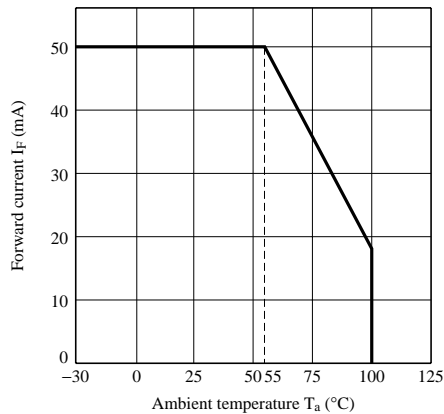
	Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input	Forward voltage	$V_F$	$I_F=20\text{mA}$	—	1.2	1.4	V
	Reverse current	$I_R$	$V_R=4\text{V}$	—	—	10	$\mu\text{A}$
	Terminal capacitance	$C_t$	$V=0, f=1\text{kHz}$	—	30	200	pF
Output	Collector dark current	$I_{CEO}$	$V_{CE}=20\text{V}, I_F=0$	—	—	100	nA
	Collector-emitter breakdown voltage	$BV_{CEO}$	$I_C=0.1\text{mA}, I_F=0$	35	—	—	V
	Emitter-collector breakdown voltage	$BV_{ECO}$	$I_E=10\mu\text{A}, I_F=0$	6	—	—	V
Transfer characteristics	Collector current	$I_C$	$I_F=5\text{mA}, V_{CE}=5\text{V}$	4.5	—	24	mA
	Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_F=20\text{mA}, I_C=1\text{mA}$	—	0.1	0.2	V
	Isolation resistance	$R_{ISO}$	DC500V 40 to 60%RH	$5 \times 10^{10}$	$1 \times 10^{11}$	—	$\Omega$
	Floating capacitance	$C_f$	$V=0, f=1\text{MHz}$	—	0.6	1.0	pF
	Cut-off frequency	$f_c$	$V_{CE}=5\text{V}, I_C=2\text{mA}$ $R_L=100\Omega, -3\text{dB}$	15	80	—	
	Response time	Rise time	$V_{CE}=2\text{V}, I_C=2\text{mA}$ $R_L=100\Omega$	—	4	18	$\mu\text{s}$
		Fall time		—	5	20	$\mu\text{s}$
	*5 Common mode rejection voltage	CMR	$I_F=0, R_L=470\Omega$ $V_{np}=100\text{mV}$ $V_{CM}=1.5\text{kV(peak)}$	10	—	—	kV/ $\mu\text{s}$

\*5 Refer to Fig.1

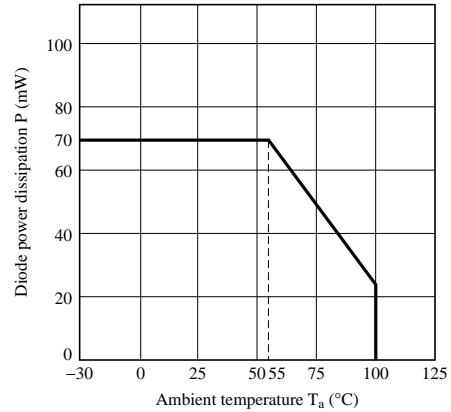
### Fig.1 Test Circuit for Common Mode Rejection Voltage



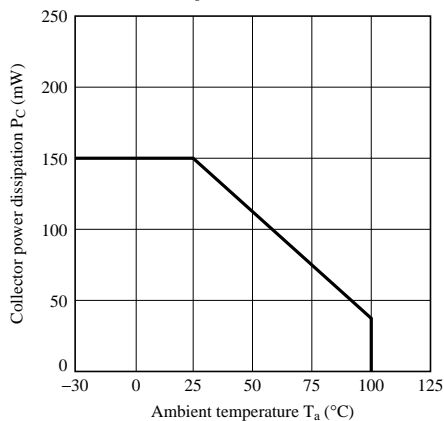
**Fig.2 Forward Current vs. Ambient Temperature**



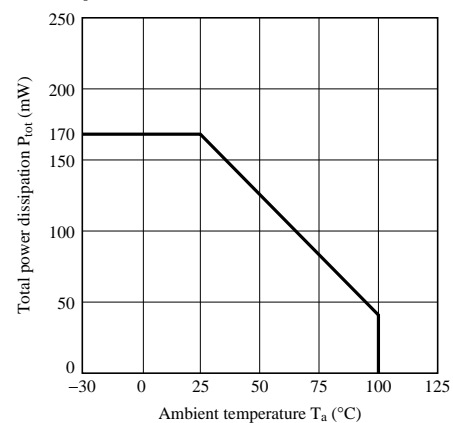
**Fig.3 Diode Power Dissipation vs. Ambient Temperature**



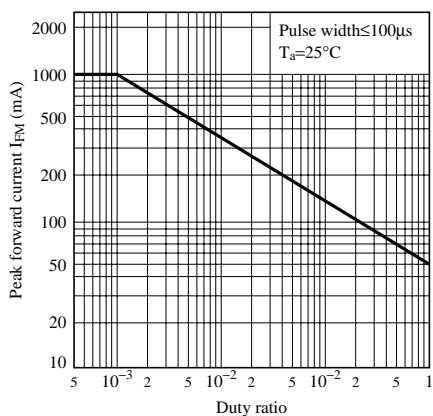
**Fig.4 Collector Power Dissipation vs. Ambient Temperature**



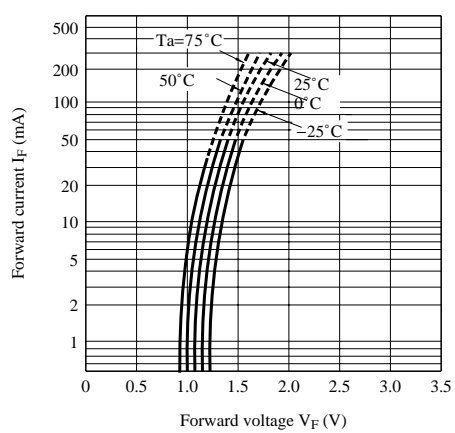
**Fig.5 Total Power Dissipation vs. Ambient Temperature**



**Fig.6 Peak Forward Current vs. Duty Ratio**



**Fig.7 Forward Current vs. Forward Voltage**



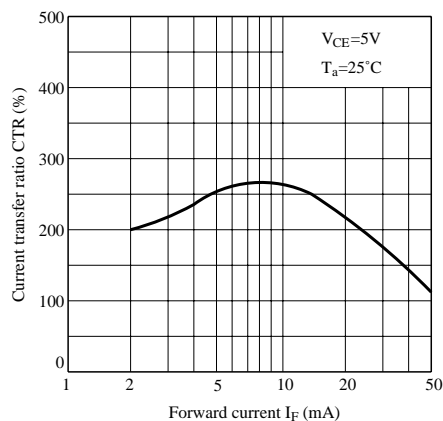
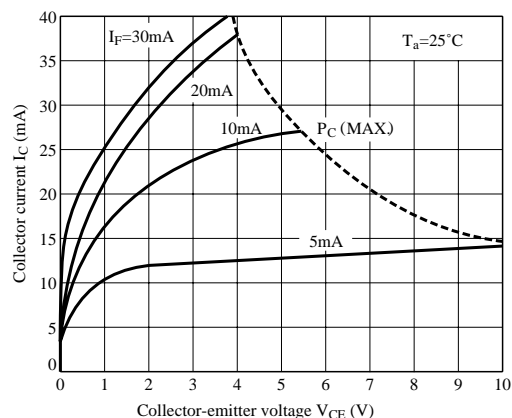
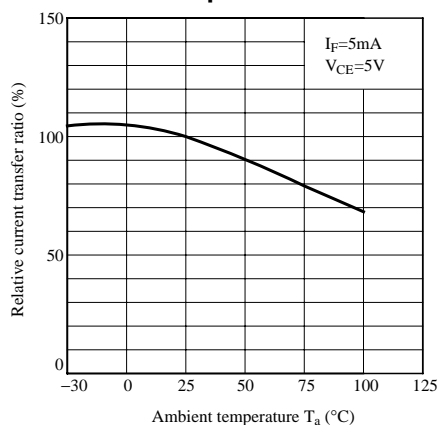
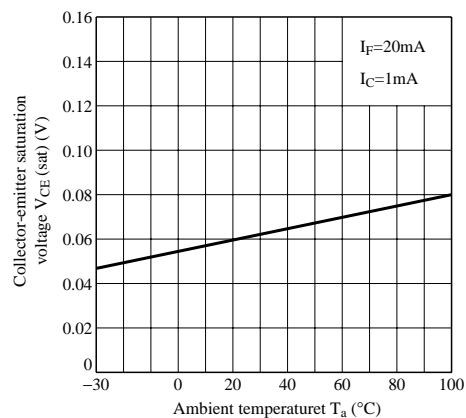
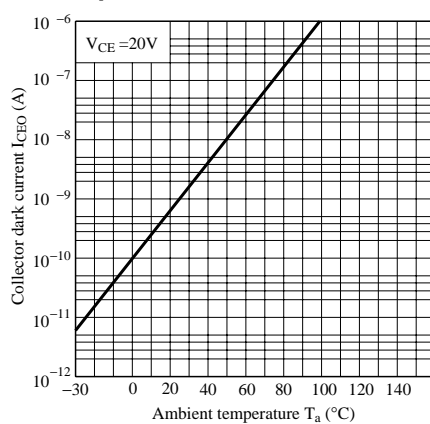
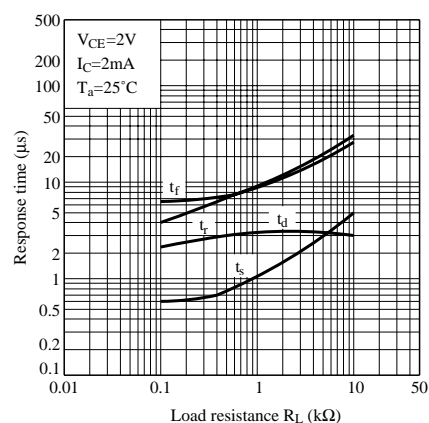
**Fig.8 Current Transfer Ratio vs. Forward Current****Fig.9 Collector Current vs. Collector-emitter Voltage****Fig.10 Relative Current Transfer Ratio vs. Ambient Temperature****Fig.11 Collector-emitter Saturation Voltage vs. Ambient Temperature****Fig.12 Collector Dark Current vs. Ambient Temperature****Fig.13 Response Time vs. Load Resistance**

Fig.14 Test Circuit for Response Time

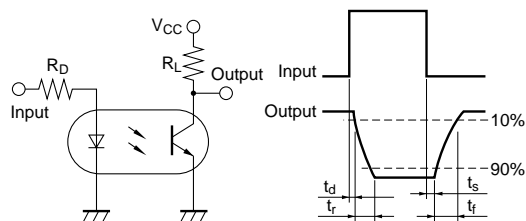


Fig.15 Voltage Gain vs Frequency

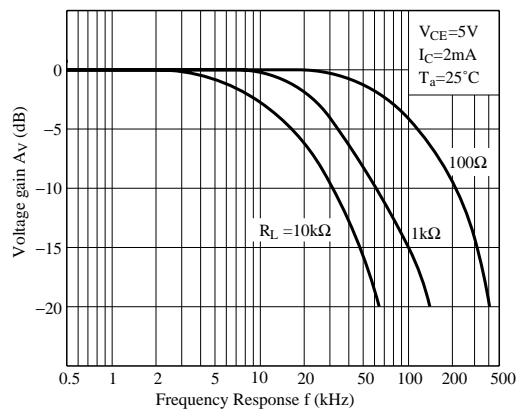


Fig.16 Collector-emitter Saturation Voltage vs. Forward Current

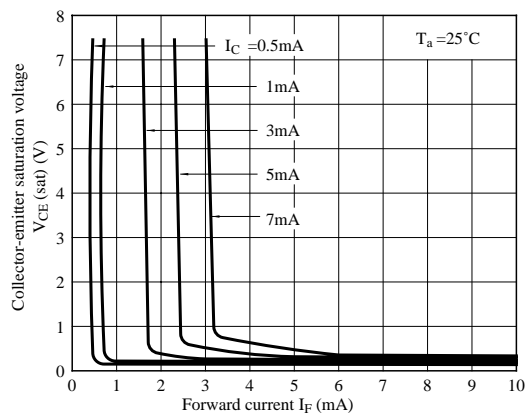
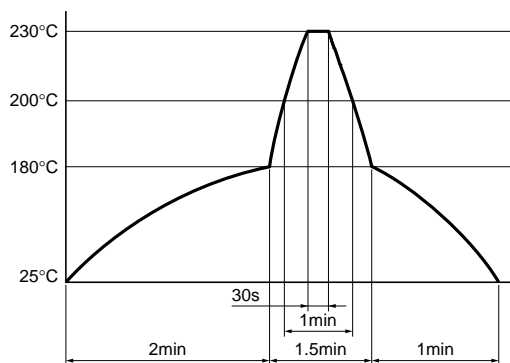


Fig.17 Reflow Soldering

Only one time soldering is recommended within the temperature profile shown below.



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